Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,979	YACH ET AL.
Examiner	Art Unit
Shew-Fen Lin	2166

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/1/2007	SFL